

Novel Prototype of a Compton Camera Based on a Monolithic GAGG Crystal*

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Traditional scintillator-based or semiconductor-based Compton Cameras generally use the method of pixelation detector to obtain the interaction position of γ -rays with detectors, which suffers from the disadvantages of complex process, high cost, strong dependence on pixelation size for position resolution, and huge electronic readout system. These disadvantages limit the development of miniaturization and commercialization of Compton Cameras. In this study, we used the whole GAGG crystal coupled Silicon Photomultiplier (SiPM) array to build two types of detectors, which are Side-readout type detector and Back-readout type detector, and developed two kinds of position reconstruction algorithm, the Response Function Method and the Photon Distribution Reconstruction Method. The position resolution of the two types of detectors was evaluated, and the position resolution of the Side-readout type detector and Back-readout type detector was 1.2 mm and 1.6 mm, respectively. In addition, we built a prototype of a double-layer Compton Camera based on a monolithic GAGG crystal using a Side-readout type detector as a scattering detector and a Back-readout type detector as an absorption detector. The position resolution of locating the radioactive source is 5.4 mm with the source placing 27 mm away from the scattering detector.

Keywords: Compton Camera, Scintillator, Position Reconstruction, SiPM

I. INTRODUCTION

Compton Cameras use the principle of Compton scattering to locate where γ -rays are generated. It has unique advantage in detection efficiency compared with other gamma-ray imaging modalities since no mechanical collimation structure is needed. [1] Compton Cameras are widely used in the fields of biomedical and radiation environmental monitoring. [2–7]

In response to the enormous market demand, several foreign companies have carried out research and development of Compton Camera, and have successively released related products, such as United States H3D company released H100[8], PHDS company released GEGI[9], Japan Institute of Aerospace Sciences (ISAS) released ASTROCAM[10], etc. Among them, ASTROCAM has been tested on-site in Fukushima and has proven its capability for hot spot detection and radioactive decontamination assessment. The domestic Compton Camera imaging technology research is still in the development stage, and related simulation and image reconstruction algorithm research has been carried out one after another, such as: Guo Xiaofeng et al. [11] have carried out research on the Compton Camera composed of CZT detector based on Geant4. Some laboratories have built Compton Camera prototypes, such as Liu Yilin [12], Tsinghua University, built Compton Cameras based on 4×4 pixel 3-D CZT detectors; Zhang Jipeng et al. [13], Institute of High Energy Chinese Academy of Sciences, constructed a double-layer Compton Camera based on GAGG crystal and SiPM array. However, self-developed Compton Camera products that can be put on the market are still blank.

At present, whether it is scintillator-based or semiconductor-based Compton cameras, the interaction

position of γ -rays is obtained by pixelating the detector [14–18]. Although the principle of this method is simple, it has obvious limitations that the reconstruction accuracy is completely dependent on the degree of pixelation of the detector. Scintillator crystals are prone to cracking and shattering during processing, making it difficult to obtain crystal arrays with small pixel sizes. Although semiconductor detectors can obtain small pixel sizes, semiconductor detectors themselves are expensive and difficult to promote. At the same time, both scintillator detection and semiconductor detection face a serious problem after increasing the degree of pixelation, that is, the unusually large electronic readout system. A bold and novel idea is to use a monolithic scintillator crystal for position reconstruction, which has the characteristics of simple structure, low cost, and easy storage compared with pixelated scintillator crystal arrays. There are very few reports of the use of monolithic scintillator crystals in Compton Cameras, mainly because it is difficult to confirm where γ -rays interact in the monolithic crystal. In recent years, with the increasing application of SiPM, this problem seems to be solvable. Traditional Compton Cameras use photomultiplier tubes (PMTs) as photoconversion devices, but PMTs are expensive, bulky and require high voltage, which cannot meet the needs of commercial Compton Cameras for low cost and miniaturization [19]. In contrast, SiPMs are small in size, high in gain, low in operating voltage, insensitive to magnetic fields, high in photon detection efficiency, and most importantly, they can be combined into any shape of detection arrays for use [20–23].

In this study, we constructed two types of detectors using the monolithic crystal coupled SiPM arrays to reconstruct the interaction position of γ -rays in the monolithic scintillator. The VMEDAQ system was used to obtain the relevant information of the interaction events in the detector. Two kinds of position reconstruction algorithm were developed to reconstruct the interaction positions of the events in the crystal, and the position resolution performance of the two types of detectors was evaluated experimentally. We used two types of

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70 detectors as scattering detectors and absorption detectors for
 71 Compton Cameras, respectively, and developed a new proto-
 72 type of Compton Camera, and experimentally tested the per-
 73 formance of this prototype.

74 II. EQUIPMENTS

75 A. The experimental equipment

76 Scintillators, such as NaI, CsI, Cerium-doped Gadolinium
 77 Aluminum Gallium Garnet(GAGG), LYSO, and LaBr₃, are
 78 often used in Compton cameras due to their relatively high de-
 79 tector efficiency and the fast time response.[24] The crystals
 80 used in this study were GAGG. Compared with other crys-
 81 tals, GAGG has the following advantages: 1. unlike NaI and
 82 LaBr₃, GAGG shows no non-hygroscopicity in air and does
 83 not need to be packaged; 2. Different from LYSO and LaBr₃,
 84 GAGG produces no internal background radiation; 3. GAGG
 85 has a higher luminescence yield and a shorter luminescence
 86 duration than the cases in CsI, which is conducive to improve
 87 the signal-to-noise ratio and energy resolution.[25, 26]

88 Traditional Compton Cameras use a pixelated crystal con-
 89 figuration, and the detector must be attached to the back of the
 90 crystal to match each pixel to get position information.[27]
 91 However, as a scattering detector, the Back-readout type de-
 92 tector will inevitably affect the outgoing γ -rays after interact-
 93 ing with the scattering detector, resulting in poor reconstruction
 94 results. In this study, a monolithic crystal was used, so a
 95 novel configuration the side-readout detector (referred to as
 96 S-type, figure 1.b) could be employed. At the same time, a
 97 Back-readout type detector (referred to as B-type, figure 1.c)
 98 was also built and used as an absorption detector for Compton
 99 Cameras. The S-type detector uses a $27 \times 27 \times 3$ mm³ GAGG
 100 crystal coupled with four 1×8 SiPM arrays (figure 1.a), and
 101 each SiPM is read out separately, with a total of 32 signals.
 102 The B-type detector uses a $27 \times 27 \times 2$ mm³ GAGG crystal cou-
 103 pled with an 8×8 SiPM array. The 8-channel SiPMs in hori-
 104 zontal of the 8×8 array are added into one signal output, so
 105 we get 8 outputs in horizontal. Similarly, the 8-channel SiPMs
 106 in longitudinal are added into one signal output, so we get 8
 107 outputs in longitudinal. SensL's C-60035 pixel SiPM was se-
 108 lected, which has a pixel area of 3×3 mm². There are 10,998
 109 micropixel APDs within each pixel, and each micropixel is 20
 110 $\mu\text{m} \times 20 \mu\text{m}$ in size. A double-layer Compton camera based on
 111 monolithic crystals was built, with an S-type detector as the
 112 scattering detector and a B-type detector as the absorption de-
 113 tector (figure 1.e). The distance between the scattering detec-
 114 tor and the absorption detector is adjustable, and the distance
 115 used in this experiment is 20 mm. VMEDAQ is used to filter
 116 the coincidence events and log the amplitude of the signal.

117 B. The S-type and B-type detector

118 The Cs-137 spectra measured by the S-type detector with
 119 and without the reflective layer are shown in figure 2(a,b), and
 120 the reflective layer material is polytetrafluoroethene. More

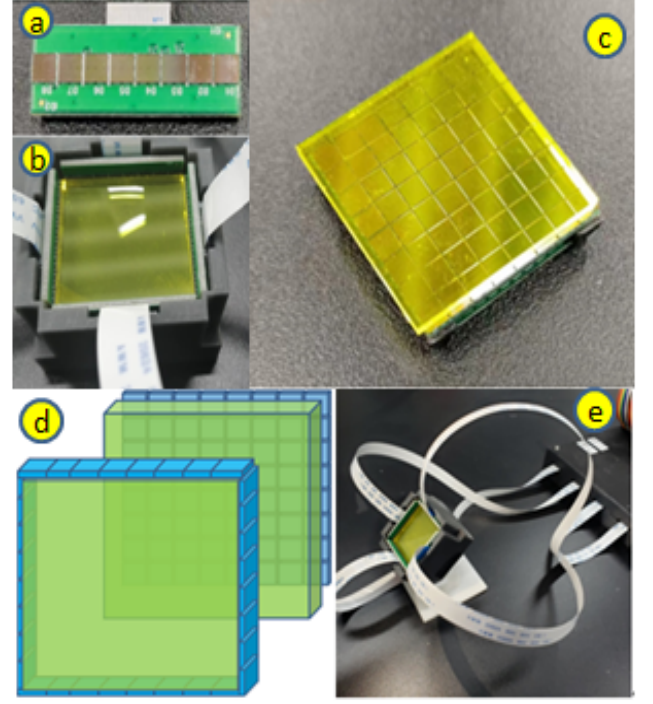


Fig. 1. a. 1×8 SiPM array; b. S-type detector; c. B-type detector; d. the schematic diagram of the Compton camera; e. the prototype of the Compton camera

121 fluorescent photons are collected when the reflective layer is
 122 wrapped, so the total energy peak address when the reflective
 123 layer is wrapped is significantly higher than that when the reflective
 124 layer is not wrapped. The resolution of the total energy peak is 8.2%
 125 when the reflective layer is wrapped, which is very close to the performance
 126 index value given by the crystal manufacturer. The energy resolution drops to 9.4%
 127 when don't wrap the reflective layer. The reflection layer has
 128 very little effect on the energy resolution of S-type detectors

129 Due to the fact that the reflective layer is not completely
 130 smooth, the fluorescent photons are diffusely reflected by the
 131 reflector layer during transmission, so the interaction position
 132 information carried by them is destroyed. To study the impact
 133 of this destruction on S-type detector, we recorded the
 134 outputs of 32-channel SiPMs by irradiating the middle of the
 135 GAGG crystal vertically from a α source in two cases :with
 136 and without the reflective layer. As mentioned above, without
 137 reflective layer results in a slight reduction of the total energy
 138 peak address, so the amplification of the amplifier is slightly
 139 increased without the reflective layer. A similar operation is
 140 performed at B-type detector. For the S-type detector, 32-
 141 channel SiPMs are distributed on the four sides of the crystal.
 142 Due to the central symmetry, Figure 3(a,b) shows the spec-
 143 trum of only 8-channel SiPMs on one side. The spectrum of
 144 SiPMs in the same geometric position on the left and right are
 145 very similar due to the left-right symmetry, so the spectrum of
 146 the 8-channel SiPMs can be divided into 4 groups. It can be
 147 seen that the spectrum difference between the four groups of
 148 SiPMs is not obvious when there is a reflective layer, which

will bring great uncertainty to reconstruct the interaction position. In the other hand if we don't wrap the reflective layer, the spectrum of the four groups of SiPMs has obvious differences, which is very beneficial for the determination of the interaction position.

For the S-type detector, the reflection layer only slightly improves energy resolution, but greatly reduces position resolution. In order to obtain better position resolution, the design of the S-type detector without the reflective layer was adopted.

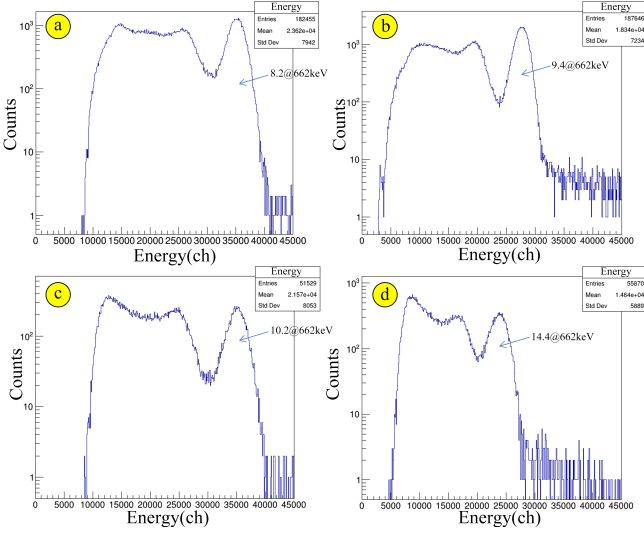


Fig. 2. The Cs-137 spectra of the S-type detector: with the reflective layer(a), without the reflective layer(b);The Cs-137 spectra of the B-type detector: with the reflective layer(c), without the reflective layer(d)

The Cs-137 spectra measured by the B-type detector with and without the reflective layer are shown in figure 2(c,d), and the reflective layer material is polytetrafluoroethene. Same as the S-type detector, for the B-type detector more fluorescent photons are collected, so the total energy peak address when the reflective layer is wrapped is higher,too. The energy resolution of the B-type detector is worse than that of the S-type detector no matter with or without the reflective layer. The main reason is that the B-type detector uses more SiPMs, and the impact of SiPM response inconsistent is greater. At the same time, the readout of the B-type detector in this study isn't one by one, but additive readout. The difference between additive circuits can also lead to a decrease in energy resolution.

The reflective layer reduces the energy resolution from 10.2% to 14.4% , which is a obvious reduction. It seems that the design of the B-type detector should be selected to wrap the reflective layer, but this study hopes to obtain better position resolution. The figure3(c,d) shows the spectrum of 8-channel outputs in the horizontal direction (the same in the vertical direction) with and without the reflective layer when the center of the B-type detector is irradiated with a α source. Due to the fixed irradiation position of the α source, theoretically, the energy spectrum of each output should be in the

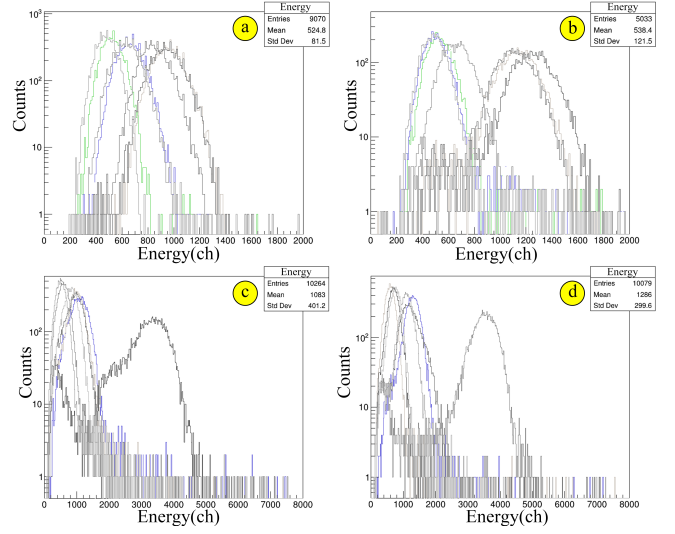


Fig. 3. the spectra of 8-channel SiPMs on the same side of the S-type detector when the interaction position is fixed at the center of the crystal: with the reflective layer(a), without the reflective layer(b); the spectra of 8-channel outputs of the B-type detector when the interaction position is fixed at the center of the crystal: with the reflective layer(c), without the reflective layer(d);

form of a Gaussian function. But in the case of wrapping the reflective layer, the energy spectrum of each channel deviates significantly from the Gaussian function. Because in this experiment, trig is set "or". If the reflective layer is not wrapped, it trig by fixed channel. But if wrapping the reflective layer, many channels may trig, resulting in the energy spectrum not the Gaussian function. Which may have a devastating impact on the position reconstruction, so the B-type still adopts the configuration without wrapping the reflective layer.

In order to improve energy resolution we will first measure the total energy of the scattering and absorbing detectors, pick out the events with the total energy as the full energy peak, and use the total energy minus the energy of the scattering detection to calculate the energy of the absorbing detector. In the future, the energy resolution can be improved by optimizing the B-type detector adduction circuit, or directly changing to the form of one by one readout.

C. The interaction position scale experiment

Interaction position scale experiments in the detector were performed using the α source (Am-241, figure 4.b) and PCB masks (figure 4.a). The thickness of the PCB mask is 2 mm, and the hole diameter and the center spacing of adjacent holes remain unchanged in the same PCB mask. Multiple PCB masks with different hole diameters and hole spacing are used in this experiment, such as a PCB with a hole diameter of 1 mm and a hole distance of 3.4 mm (PCB (ϕ 1.0, D3.4)). The α source is placed in each hole in turn. The interaction position of these events is approximately considered to be the same position, and its coordinates x,y are taken from the co-

ordinates of the center of the hole, and its coordinates z is a fixed value (1.5 mm for the S-type detector and 1.0 mm for the B-type detector). (figure 4.c)

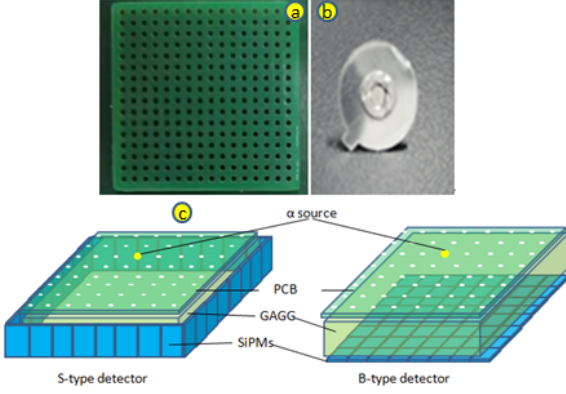


Fig. 4. The PCB mask(A), α source(B) The interaction position reconstruction experiment S-type and B-type detector(C)

III. ALGORITHM

In this study, two kinds of reconstruction algorithm is developed to reconstruct the interaction position (x, y, z) where the γ -ray interacts with the detector: the response function method and the photon distribution reconstruction method. In both algorithm, z is taken as a fixed value. The response function method can be used to reconstruct the interaction position only for S-type detector, it's not work for B-type detector. The photon distribution reconstruction method can be used in both types of detector.

A. The Response Function Method

Assuming that the scintillator is homogeneous and the fluorescence photons are emitted uniformly in 4π , so more fluorescent photons can be received, when the interaction point is closer to the SiPM. For example, the α sources are placed sequentially at 8 test points in the black box in figure 5(left). E_{up} represents the energy deposited in the $SiPM_{up}$, and E_{down} indicates the energy deposited in the $SiPM_{down}$. As the position of the interaction changes, the E_{down}/E_{up} also changes, satisfying a certain response function, as shown in the figure 5(right). Repeating the above operations, the response functions of the whole detector (8 horizontal and 8 vertical) can be obtained. Then the x, y values of any event can be reconstructed by using these response functions. This algorithm is only applicable in S-type detectors because similar response functions cannot be obtained in B-type detectors.

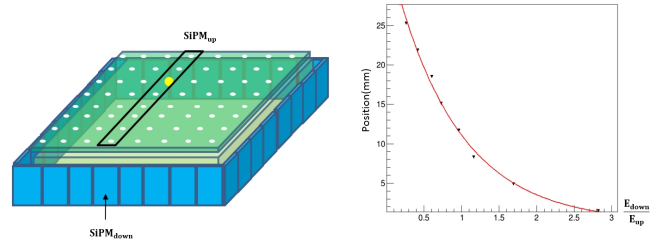


Fig. 5. 8 test points in a row(left), the response function(right)

B. The Photon Distribution Reconstruction Method

When a single fluorescent photon is received by the SiPM, a pulse of a certain amplitude is produced as the output. When multiple fluorescent photons are received, the output signal is the superposition of all the fluorescent photon producing signals:

$$V_i = V_{i0} \cdot N_i \quad (1)$$

V_i is the amplitude of the output signal of the $SiPM_i$, N_i is the number of fluorescent photons received by the $SiPM_i$, V_{i0} is the amplitude of the output signal when the $SiPM_i$ receives single fluorescent photon. The number of fluorescent photons received by the $SiPM_i$ is strongly correlated with the solid angle of the $SiPM_i$ subtended to the interaction position:

$$N_i = N_0 \cdot E \cdot \Omega_i \quad (2)$$

N_0 is the number of fluorescent photons per solid angle at the unit energy deposited, and E is the energy deposited at that point. Assuming that the fluorescence emission at the interaction position is uniform at 4π , ignoring the fluorescence attenuation caused by the self-absorption of the crystal, then the N_0 is only a fixed value related to the luminescence yield of the crystal. Ω_i is the solid angle of the SiPM i subtended to the interaction position, as show in figure 6.

The ADC value of the SiPM i output signal is ADC_i :

$$ADC_i = a_i \cdot V_i + b_i \quad (3)$$

a_i and b_i are the scaling coefficients of the signal amplitude with the ADC address, which can be obtained experimentally and are fixed values.

$$\begin{aligned} ADC_i &= a_i \cdot V_{i0} \cdot N_0 \cdot E \cdot \Omega_i + b_i \\ &= K_i \cdot E \cdot \Omega_i + b_i \end{aligned} \quad (4)$$

When the unit energy is deposited in the crystal, the ADC value which the SiPM i receives photons in the unit solid angle can be calculated using the formula (4). K_i, b_i are the conversion coefficient, can be measured experimentally. Before introduce the experiment, let's explain how to calculate Ω_i .

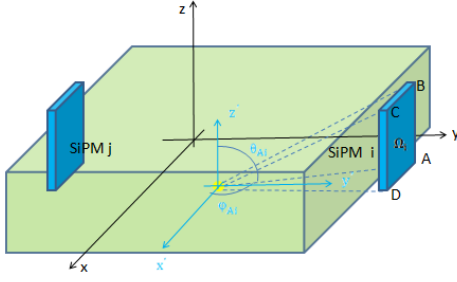


Fig. 6. The solid angle of the SiPM i and SiPM j subtended to the interaction position.

Taking the crystal center as the origin (0,0,0) of the xyz coordinate, the spatial coordinates of the 32 SiPMs have been determined, which is a known quantity. Taking *SiPM_i* as an example, the coordinates of point A (x_{Ai}, y_i, z_{Ai}), point B (x_{Bi}, y_i, z_{Bi}), point C coordinates (x_{Ci}, y_i, z_{Ci}), and point D coordinates (x_{Di}, y_i, z_{Di}). y_i is fixed values for the same SiPM. In this case, if an interaction occurs at any position in the crystal (x,y,z), the solid angle of *SiPM_i* relative to the interaction position can be Ω_i obtained by integrating φ_{Ai} and θ_{Ai} in the $x'y'z'$ coordinate. In the $x'y'z'$ coordinate system, the coordinates of the relative interaction positions of ABCD points are transformed into A($x_{Ai}-x, y_i-y, z_{Ai}-z$), point B coordinates ($x_{Bi}-x, y_i-y, z_{Bi}-z$), point C coordinates ($x_{Ci}-x, y_i-y, z_{Ci}-z$), and point D coordinates ($x_{Di}-x, y_i-y, z_{Di}-z$). There will be a slight change in θ during the integration from point A to point D, but this change is negligible unless the interaction position is very close to the SiPM. So in the following integration process, θ is considered unchanged from point A to point D.

$$\Omega_i = \int_{\varphi_{Ai}}^{\varphi_{Di}} \int_{\theta_{Ai}}^{\theta_{Bi}} \sin\theta d\theta d\varphi \quad (5)$$

$$= \int_{\varphi_{Ai}}^{\varphi_{Di}} ((-\cos\theta_{Bi}) - (-\cos\theta_{Ai})) d\varphi \quad (6)$$

$$\cos\theta_{Ai} = \frac{z_{Ai} - z}{\sqrt{((y_i - y) \cdot \frac{1}{\tan\varphi_{Ai}})^2 + (y_i - y)^2 + (z_{Ai} - z)^2}} \quad (7)$$

suppose:

$$k_{Ai} = \frac{y_i - y}{z_{Ai} - z} \quad (8)$$

so:

$$\cos\theta_{Ai} = \frac{1}{\sqrt{(\frac{k_{Ai}}{\sin\varphi_{Ai}})^2 + 1}} \quad (9)$$

in the same way:

$$\cos\theta_{Bi} = \frac{1}{\sqrt{(\frac{k_{Bi}}{\sin\varphi_{Bi}})^2 + 1}} \quad (10)$$

Substituting the formula(5), formula(6) into the formula(3):

$$\Omega_i = \int_{\varphi_{Ai}}^{\varphi_{Di}} \left(\frac{1}{\sqrt{(\frac{k_{Ai}}{\sin\varphi_{Ai}})^2 + 1}} - \frac{1}{\sqrt{(\frac{k_{Bi}}{\sin\varphi_{Bi}})^2 + 1}} \right) d\varphi \quad (11)$$

Here by looking up the indefinite integral table:

$$\int \frac{1}{(\frac{k}{\sin x})^2 + 1} dx = \quad (12)$$

$$\frac{\sqrt{-1 - 2k^2 + \cos^2 x} \cdot \csc x \cdot \log(\sqrt{2} \cdot \cos x + \sqrt{-1 - 2k^2 + \cos^2 x})}{\sqrt{2 + 2k^2} \cdot \csc^2 x} \quad (13)$$

$$k : \text{constant} \quad (14)$$

Equation (13) contains plural terms, but after merging and sorting, the plural terms are no longer existing, and the final result is:

$$\begin{aligned} \Omega_i = & \arctan\left(\frac{\sqrt{2k_{Ai}^2 + 2\sin^2\varphi_{Ai}}}{\sqrt{2}\cos\varphi_{Ai}}\right) - \arctan\left(\frac{\sqrt{2k_{Ai}^2 + 2\sin^2\varphi_{Di}}}{\sqrt{2}\cos\varphi_{Di}}\right) \\ & + \arctan\left(\frac{\sqrt{2k_{Bi}^2 + 2\sin^2\varphi_{Ai}}}{\sqrt{2}\cos\varphi_{Ai}}\right) - \arctan\left(\frac{\sqrt{2k_{Bi}^2 + 2\sin^2\varphi_{Di}}}{\sqrt{2}\cos\varphi_{Di}}\right) \end{aligned} \quad (15)$$

$$\sin\varphi_{Ai} = \frac{y_i - y}{\sqrt{(y_i - y)^2 + (x_i - x)^2}} \quad (16)$$

$$\cos\varphi_{Ai} = \frac{x_i - x}{\sqrt{(y_i - y)^2 + (x_i - x)^2}} \quad (17)$$

The transformations of φ_{Bi} and φ_{Di} are similar to those of φ_{Ai} .

The solid angle of the any interaction position to SiPMi can be calculated now. Next, the K_i, b_i are measured experimentally. A α source was placed at any position in the crystal, the solid angle of the 32-channel SiPMs were theoretically calculated, and the ADC value of the 32-channel SiPMs were recorded experimentally. Then, the position of the α source was changed, the solid angle of the 32-channel SiPMs were calculated theoretically, and the ADC value of the 32-channel SiPMs were recorded experimentally. Theoretically, the values of K_i, b_i can be obtained in two experiments, and in order to reduce the experimental error, the method of multiple experimental iterations of K_i, b_i is adopted. The decision condition for the iteration is that the difference between the center value of the 32-channel SiPMs experimental energy spectrum

(the blue line in figure 7) and the theoretical calculated expected value (the red line in figure 7) is the smallest. The figure 7 shows the comparison of the 32-channel experimental energy spectrum and the theoretical calculated expected value at a certain experimental point. The K_i, b_i ensure that the total difference between the theoretical and experimental values of the 32 SiPMs is smaller, so the experimental center value is slightly different from the theoretical calculated value in some SiPMs.

The Photon Distribution Reconstruction Method is not directly using the ADC value to calculate the position. The values of the 32-channel ADC at the interaction position can be calculated using Equation (4). First, 32-channel ADC values are counted as a set of data at one interaction position. Then change the interaction position to get another set of data. Finally, repeat the process to make a database. When an unknown interaction position event occurs, a set of 32-channel ADC values is obtained, and the 32 ADC values are compared with each set of data in the database to find the most similar set of interaction position. The set that can best reproduce the photon distribution of the signal is the reconstructed position. Therefore, the larger the database, the higher the accuracy of the reconstruction. Experimentally, it's hard to make a large database. But using Equation (4), we can make a database of any size.

The solid angle of the SiPMi relative to any interaction position in the figure 6 can be calculated using the formula (15), which is only a schematic diagram of the S-type detector. If the crystal in the figure 6 is compressed in the y direction and elongated in the z direction, the schematic diagram of the B-type detector is obtained, so the formula (15) is still valid for the B-type detector. Therefore, the photon distribution reconstruction method can also be applied to B-type detectors.

IV. RESULT

A. The reconstruction result of the Response function method

Figure 8 shows the experimental results of the reconstruction using PCB ($\phi 1.0$, D3.4) using the response function method. The red dot is the hole position of PCB ($\phi 1.0$, D3.4) in the experiment, and the black dot is the central value of the reconstruction position, and the uncertainty is the FWHM (full width at half maximum) of the reconstruction position of the same hole event. Approximately 3,000 reconstruction events were counted at each experimental site.

As can be seen from the figure, the central value of the reconstruction position is basically the same as the experimental position, the average deviation of the 64 experimental points is about 0.3 mm (both the x and y direction). There is obvious deviation in data of the second to last, around 5 mm in vertical axis, comparing with other results. The reason is that the response function in figure 5 (right) changes rapidly around 5 mm. Due to the lack of experimental points, the response function cannot well describe the trend change of this part, resulting in poor position reconstruction results in this part. The uncertainty of the reconstruction position is rela-

tively large. The main reason for these problems is that only part of the fluorescent photons are collected by each SiPM, and the statistical fluctuation of the fluorescence photon number is very large, so it is necessary to use as many SiPMs as possible to reduce the impact of statistical fluctuations when reconstructing the location.

B. The reconstruction result of the Photon Distribution Reconstruction Method.

The reconstruction results of the photon distribution reproduction method are shown in figure 9 (S-type detector, PCB ($\phi 1.0$, D3.4), left) and figure 9 (B-type detector, PCB ($\phi 1.0$, D3.4), right). The red dot is the hole position of PCB ($\phi 1.0$, D3.4) in the experiment, and the black dot is the central value of the reconstruction position, and the uncertainty is the FWHM (full width at half maximum) of the reconstruction position of the same hole event. Approximately 3,000 reconstruction events were counted at each experimental site.

The whole crystal is divided into two parts: the middle 6*6 36 experimental points and the outermost circle of 28 experimental points, the middle 6*6 is called the central part, and the outermost circle is called the edge part. For the S-type detector, the average deviation of the experimental points is about 0.3 mm (both the x and y direction) in the central part, which is same as the response function method. For the B-type detector, the average deviation of the experimental points is about 0.4 mm (both the x and y direction) in the central part, which is slightly higher than the response function method. In the edge part, the average deviation become 0.5 mm (both the x and y direction) for the S-type detector, and 0.7 mm for the B-type detector. Because the closer to the edge of the crystal, the more serious the damage to the position information caused by the optical scattering of fluorescence.

The above reconstruction results show that the event with the interaction location at the edge part of the detector is not as good as the event in the center part. In the next experiment to determine the position-resolved limit, the edge part of the event will not be considered, and the event in the center of the detector will be mainly focused.

C. The position-resolved limit experiments

The position resolution limit has been investigated by applying PCB masks with the different hole spacing. In order to reduce the uncertainty of the interaction position caused by the hole size, the hole diameter of the PCB board with a hole spacing of less than 2 mm is changed to 0.5 mm. Figure 10(up) shows the position reconstruction result (x-direction projection) using the PCB ($\phi 0.5$, D1.2) for the S-type detector, and Figure 10(down) shows the position reconstruction result (x-direction projection) using the PCB ($\phi 0.5$, D1.6) for the B-type detector.

The reconstruction algorithm used in the position-resolved limit experiment is the photon distribution reproduction method, which is used for both S-type and B-type detectors.

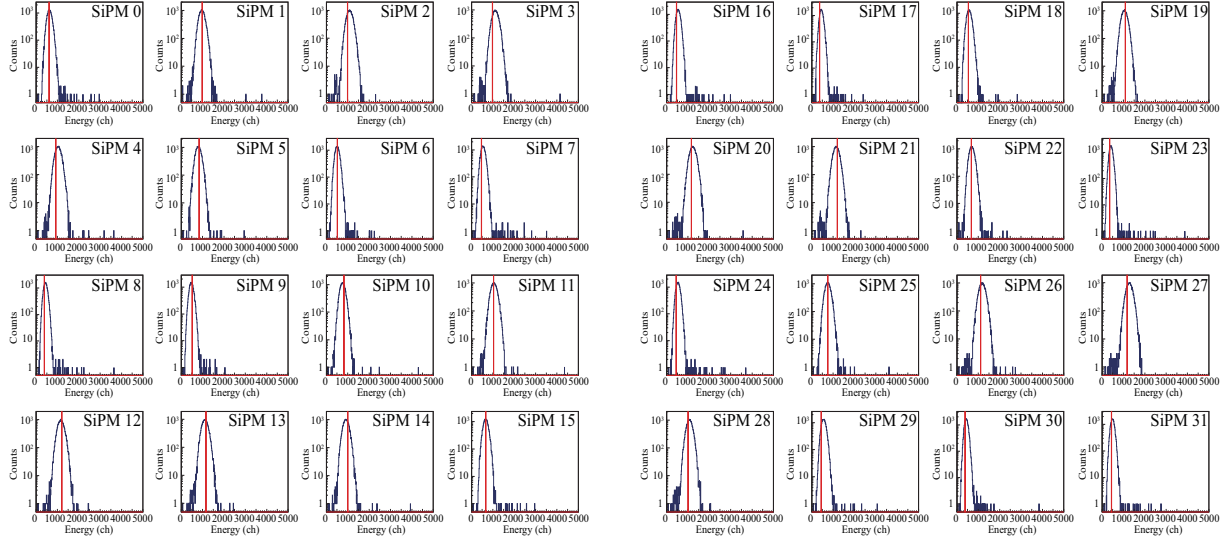


Fig. 7. the 32-channel experimental energy spectrum(blue line) and the theoretical calculated expected value(red line) at a certain experimental point

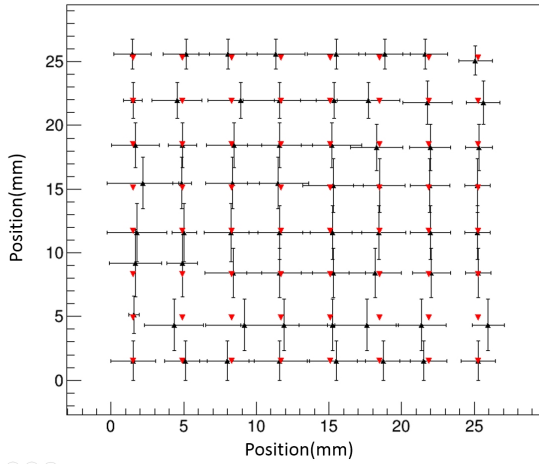


Fig. 8. The reconstruction result of the response function method(S-type detector, PCB (1.0, 3.4))

The figure 10(up) shows a total of 11 peaks from 8 mm to 22 mm, and the average spacing between the two peaks is about 1.27 mm, which is basically the same as the 1.2 mm hole spacing of the PCB board, indicating that the position resolution limit of the S-type detector is about 1.2 mm.

The figure 10(down) shows a total of 12 peaks from 5.5 mm to 26 mm, and the average spacing between the two peaks is about 1.71 mm, which is slightly larger than the 1.6 mm hole spacing on the PCB board, indicating that the position resolution limit of the B-type detector is about 1.6 mm. The reason why the position resolution limit is 1.6 mm instead of the more conservative 1.7 mm is that except for peaks 2,3 and peaks 9,10, which overlap significantly, the other peaks are very well distinguished, which should further reduce the hole spacing of the PCB. The reason for the overlap of peaks 2,3

and peaks 9,10 is that the positions of the holes of peaks 3 and 9 are exactly the gap positions of the two SiPMs in the SiPM array, and the gap width of the two SiPMs is about 0.43 mm, which is basically the same as the hole diameter of the PCB board of 0.5 mm. When the interaction sites are located at peaks 3 and 9, a large number of fluorescent photons are not received by the SiPMs, but escape through the gap between the SiPMs, which also explains why the counts at peaks 3 and 9 are significantly smaller. This problem does not exist for the S-type detector, where the S-type detector uses 32 SiPMs for position reconstruction at the same time, and when the interaction position is in the gap between one of the two SiPMs, the remaining 30 SiPMs can be used for position reconstruction without particularly affecting the reconstruction results.

V. THE COMPTON CAMERA PRINCIPLE PROTOTYPE AND PERFORMANCE TESTING

A double-layer Compton Camera based on monolithic crystals was built, with an S-type detector as the scattering detector and a B-type detector as the absorption detector (figure 1.e). The spacing between the scattering detector and the absorption detector was 20 mm. Cs-137 point source (about 1 mm in diameter) was used as the imaging object in this study. The Cs-137 was placed two positions 27 mm away from the vertical direction of the scattering detector, and the two positions were 8 mm apart in the same imaging plane. Both the S-type detector and the B-type detector use the Photon Distribution Reconstruction Method to reconstruct the interaction position. Figure 11 shows the reconstruction results for the two positions. Use the FWHM of the reconstruction result as the spatial resolution, so the spatial resolution at 27 mm is about 5.4 mm.

Compared with the existing Compton Cameras, Turecek et al. [28] developed a double-layer Compton Camera composed

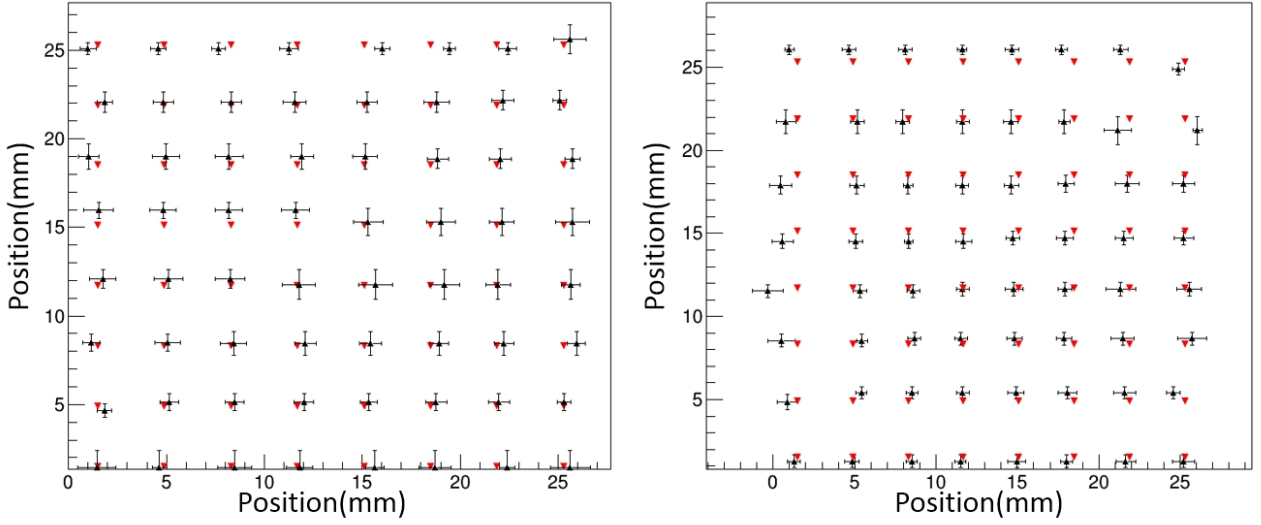


Fig. 9. The reconstruction result of the S-type detector(left) and B-type detector(right) using the photon distribution reconstruction method (PCB ($\phi 1.0$, D3.4))

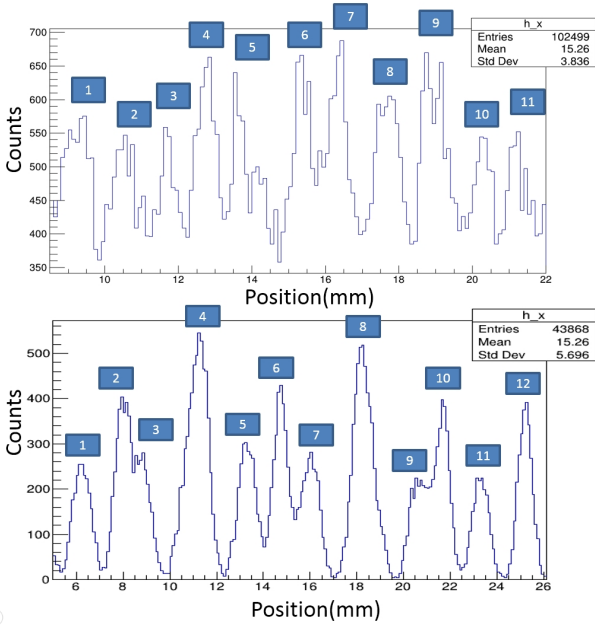


Fig. 10. The limit of position resolution of S-type detector-PCB(1.2,up).The limit of position resolution fo B-type detector-PCB(1.6,down)

detector is much lower than that of the semiconductor detector. However, the high processing cost of semiconductor detectors, harsh working conditions and complex electronic systems make it difficult to commercialize semiconductor-based Compton Cameras at low cost. The Compton Camera based on the monolithic scintillator crystal built in this study is low-cost, simple in structure, and slightly lower in detection performance than the semiconductor-based Compton Camera, which undoubtedly has greater possibilities in low-cost commercialization.

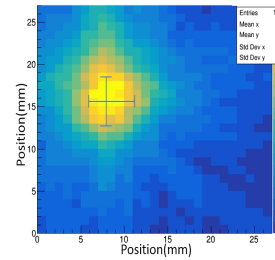


Fig. 11. The reconstruction results of Cs-137 at two points(8mm apart).

of a 1 mm thick silicon detector and a 2 mm thick CdTe detector based on the pixel array semiconductor detector Timepix3, with a spatial resolution of up to 2.5 mm at 25 mm, which is one of the Compton Cameras with the most ideal imaging effect of the double-layer semiconductor detector structure today. The spatial resolution of the Compton Camera based on the whole scintillator is lower than that of the detector, mainly because the energy resolution of the scintillator

VI. DISCUSSION

Most of the existing Compton Cameras use pixelated crystals to determine the position of the interaction position.[29, 30] There is no doubt that the higher pixelation, the higher accurate we can get. But as the level of pixelation increases, a series of problems arise. The following discussion only considers the case where the detector is scintillator detector, and

does not consider the case where the detector is semiconductor detector or gas detector. 1.The processing difficulty and cost of crystals will inevitably increase, and the level of pixelation cannot be increased indefinitely. Taking the $27 \times 27 \times 3$ mm GAGG crystal used in this study as an example, if the pixelated crystal method is used to achieve 1.2 mm position resolution, the crystal pixels need to be divided into a $1.2 \times 1.2 \times 3$ mm 23×23 array, and the processing cost will become 3-4 times. 2.In order to determine the interaction position, each pixel needs to have an independent data acquisition, with the increase of the level of pixelation, the acquisition system will become very redundant, and the redundant acquisition system will bring problems such as reduced signal-to-noise ratio and serious crosstalk. For example, in this study, the S-type detector achieves a position resolution of 1.2 mm using 32 data acquisition channels. If a traditional configuration is used to achieve the same position resolution, even using weighting calculation such as Anger logic, the number of data acquisition channels required would be significantly more than 32[31]. 3.Because the pixelated crystal must be coupled with the acquisition system one by one, its configuration can only be similar to the B-type detector in this study, and if the multi-layer B-type detector is used, there must be γ -ray to react with the electronic device instead of the crystal, which reduces the detector efficiency. The use of multi-layer S-type detectors will greatly reduce the efficiency degradation caused by this phenomenon.

In this study, we proposed a method for reconstructing the interaction position in monolithic crystals, and achieved good reconstruction accuracy, which can be used in many fields. In the study of nuclear reactions and nuclear structure, track measurement is an important research method, usually using equipment such as solid track detectors, ionization chambers or time projection chambers[32, 33], which mainly respond to charged particles and have low detection efficiency for γ -rays. In the future, the technology in this study can be used to combine multiple S-type detectors into a telescope detector system, which will obtain a good γ -rays trace. In the field of medical imaging, both single-photon emission computed tomography (SPECT) and positron emission tomography (PET) require accurate measurements of the interaction position of γ -rays. The detectors currently used are semiconductor detectors (CdTe, CZT, etc.) or pixelated scintillator detectors (CLYC, CsI, etc.)[34, 35]. The technology in this study can reduce costs, simplify the system structure, and improve the

detection accuracy. In addition, this technology has the opportunity to play a role in the fields of μ imaging, radioactive survey, radiation protection, etc.

This study is only a preliminary study of the reaction position reconstruction and the construction of Compton Cameras using monolithic crystals, and there is still a lot of work to be done. First of all, the S-type detector used a thin slice structure in this study, and the thickness of 3 mm can only be coupled with a layer of SiPM, which makes the z-direction cannot be determined, and only a fixed value can be taken. In the future, the thickness of the crystal can be increased, multilayer SiPM can be coupled, and the photon distribution can be used to determine the position in the z-direction. Secondly, the algorithm used in this study only considers the solid angle, but does not consider the optical transmission properties of photons in the crystal, which leads to the deterioration of the reconstruction accuracy of the edge part, and the optical transmission properties can be added to the algorithm to improve the reconstruction accuracy in the future. For the Compton Camera, the S-type detector is used as the scattering detector and the B-type detector is the two-layer configuration of the absorption detector, and the configuration of the multilayer S-type detector can be used to improve the detection efficiency in the future.

VII. CONCLUSION

In this paper, a prototype Compton Camera based on a monolithic GAGG crystal is built, with the S-type detector as the scattering detector and the B-type as the absorption detector. With two types of position reconstruction algorithm developed in the present work, the interaction position in the scattering and the absorption detectors can be determined with the resolution of 1.2 mm and 1.6 mm, respectively. Using Cs-137 as a point source, the position of the source can be determined with a resolution of 5.4 mm when the source was 27 mm away from the scattering detector.

The monolithic crystal based Compton Camera developed in the present work has the advantages of low cost, simple and compact in structure. The moderate imaging performance also meets the requirements of the radioactive source positioning and nuclear medicine in nuclear industry applications. These facts show the high potential of the monolithic crystal based Compton Camera to be commercialized.

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